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Application Number	FBA 10619648
Filing Date	July 14, 2003
First Named Inventor	Steven R. HETZLER
Art Unit	TBA
Examiner Name	TBA
Attorney Docket Number	APC0 2003 0040 US4

			U. S. PATENT	DOCUMENTS	
Examiner Initials*	Cita No.1	Document Number Number-Kind Code ^{2 (1}	Publication Date MM-DD-YYYY	Name of Patenties or Applicant of Cited Document	Pagas, Columns, Unes, Where Relevant Passages or Relevant Figures Appear
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				Application Number	JBA-	10619648	\
			CLOSURE	Filing Date	July 14	, 2003	
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		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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Examiner Signature (Date Considered	5	19	ob

^{*}EXAMINER: Initial Maniferance considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered, include copy of this form with next communication to applicant.

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2009010				Application Number	TBA	10619648	
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